Application/Confrol No. 10/020,314 Applicant(s)/Patent Under Reexamination SHIMAMOTO ET AL. Examiner Khiem D Nguyen Applicant(s)/Patent Under Reexamination SHIMAMOTO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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